

<b>Search Notes</b> 	<b>Application No.</b> 10/045,907	<b>Applicant(s)</b> CACHIN ET AL.
	<b>Examiner</b> Tan Lien	<b>Art Unit</b> 2141

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	203-206	3/1/2005	TL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Srch	3/1/2005	TL
Con't Srch (PALM)	2/17/2005	TL
EAST (US Patent & PGPub, EPO, JPO)	3/1/2005	TL
PLUS Srch	2/18/2005	TL
ACM Digital Library	2/18/2005	TL
IEEE Xplore	2/18/2005	TL
Asked EIC for srch help in an Article	2/18/2005	TL
Consulted with primaries (Dung Dinh, Mark Tompson, Ken Coulter, Le Luu)	5/18/2005	tl